## **Power MOSFET**

# 20 V/-20 V, 4.6 A/-4.1 A, μCool™ Complementary, 2x2 mm, WDFN Package

#### **Features**

- Complementary N-Channel and P-Channel MOSFET
- WDFN Package with Exposed Drain Pad for Excellent Thermal Conduction
- Footprint Same as SC-88 Package
- Leading Edge Trench Technology for Low On Resistance
- 1.8 V Gate Threshold Voltage
- Low Profile (< 0.8 mm) for Easy Fit in Thin Environments
- This is a Pb-Free Device

#### **Applications**

- Synchronous DC-DC Conversion Circuits
- Load/Power Management of Portable Devices like PDA's, Cellular Phones and Hard Drives
- Color Display and Camera Flash Regulators

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

| Parar   | neter           |                        | Symbol                            | Value         | Unit |  |
|---|-----------------|------------------------|-----------------------------------|---------------|------|--|
| Drain-to-Source Volta   | N-Ch            | $V_{DSS}$              | 20                                | V             |      |  |
|   | P-Ch            |                        | -20                               |               |      |  |
| Gate-to-Source Voltag   | je              | N-Ch                   | $V_{GS}$                          | ±8.0          | V    |  |
|   |                 | P-Ch                   |                                   |               |      |  |
| N-Channel   | Steady          | $T_A = 25^{\circ}C$    | I <sub>D</sub>                    | 3.8           | Α    |  |
| Continuous Drain Current (Note 1)                                 | State           | $T_A = 85^{\circ}C$    |                                   | 2.8           |      |  |
| , ,   | t≤5s            | $T_A = 25^{\circ}C$    |                                   | 4.6           |      |  |
| P-Channel   | Steady          | T <sub>A</sub> = 25°C  | I <sub>D</sub>                    | -3.3          | Α    |  |
| Continuous Drain<br>Current (Note 1)                              | State           | $T_A = 85^{\circ}C$    |                                   | -2.4          |      |  |
| Ourient (Note 1)  | t≤5s            | $T_A = 25^{\circ}C$    |                                   | -4.1          |      |  |
| Power Dissipation   | Steady          |                        | $P_{D}$                           | 1.5           | W    |  |
| (Note 1)  | State           | $T_A = 25^{\circ}C$    |                                   |               |      |  |
|   | t ≤ 5 s         |                        |                                   | 2.3           |      |  |
| N-Channel<br>Continuous Drain                                     | Steady          | $T_A = 25^{\circ}C$    | I <sub>D</sub>                    | 2.6           | Α    |  |
| Current (Note 2)  | State           | T <sub>A</sub> = 85°C  |                                   | 1.9           |      |  |
| P-Channel   | Steady          | $T_A = 25^{\circ}C$    | $I_{D}$                           | -2.3          | Α    |  |
| Continuous Drain<br>Current (Note 2)                              | State           | T <sub>A</sub> = 85°C  |                                   | -1.6          |      |  |
| Power Dissipation (Note 2)  | Steady<br>State | T <sub>A</sub> = 25°C  | $P_{D}$                           | 0.71          | W    |  |
| Pulsed Drain Current  | N-Ch            | t <sub>p</sub> = 10 μs | I <sub>DM</sub>                   | 18            | Α    |  |
|   | P-Ch            | 1                      |                                   | -20           |      |  |
| Operating Junction and Storage Temperature                        |                 |                        | T <sub>J</sub> , T <sub>STG</sub> | –55 to<br>150 | °C   |  |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s) |                 |                        | TL                                | 260           | °C   |  |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
- Surface Mounted on FR4 Board using the minimum recommended pad size of 30 mm<sup>2</sup>, 2 oz Cu.



#### ON Semiconductor®

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| V <sub>(BR)DSS</sub> | R <sub>DS(on)</sub> MAX | I <sub>D</sub> MAX |
|----------------------|-------------------------|--------------------|
| N-Channel<br>20 V    | 65 m $\Omega$ @ 4.5 V   | 3.8 A              |
|                      | 85 m $\Omega$ @ 2.5 V   | 2.0 A              |
|                      | 120 mΩ @ 1.8 V          | 1.7 A              |
| D. Obsessed          | 100 mΩ @ –4.5 V         | -4.1 A             |
| P-Channel<br>-20 V   | 135 m $\Omega$ @ –2.5 V | -2.0 A             |
|                      | 200 mΩ @ –1.8 V         | -1.6 A             |

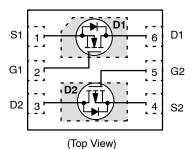
## **MARKING DIAGRAM** WDFN6 JMM= **CASE 506AN**

JM = Specific Device Code = Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

#### PIN CONNECTIONS



#### **ORDERING INFORMATION**

| Device        | Package            | Shipping <sup>†</sup> |
|---------------|--------------------|-----------------------|
| NTLJD3119CTAG | WDFN6<br>(Pb-Free) | 3000/Tape & Reel      |
| NTLJD3119CTBG | WDFN6<br>(Pb-Free) | 3000/Tape & Reel      |

†For information on tape and reel specifications. including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

## THERMAL RESISTANCE RATINGS

| Parameter   | Symbol         | Max | Unit |
|---|----------------|-----|------|
| SINGLE OPERATION (SELF-HEATED)                      |                |     |      |
| Junction-to-Ambient - Steady State (Note 3)         | $R_{	hetaJA}$  | 83  |      |
| Junction-to-Ambient - Steady State Min Pad (Note 4) | $R_{	hetaJA}$  | 177 | °C/W |
| Junction-to-Ambient – $t \le 5$ s (Note 3)          | $R_{	hetaJA}$  | 54  |      |
| DUAL OPERATION (EQUALLY HEATED)                     |                |     |      |
| Junction-to-Ambient - Steady State (Note 3)         | $R_{	hetaJA}$  | 58  |      |
| Junction-to-Ambient - Steady State Min Pad (Note 4) | $R_{	hetaJA}$  | 133 | °C/W |
| Junction–to–Ambient – t ≤ 5 s (Note 3)              | $R_{	heta JA}$ | 40  |      |

Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
 Surface Mounted on FR4 Board using the minimum recommended pad size (30 mm², 2 oz Cu).

## **ELECTRICAL CHARACTERISTICS** (T<sub>1</sub> = 25°C unless otherwise noted)

| Parameter                         | Symbol                               | N/P   | Test Condition  | ons                        | Min  | Тур  | Max  | Unit  |
|-----------------------------------|--------------------------------------|---|---|----------------------------|------|------|------|-------|
| OFF CHARACTERISTICS               | I                                    |   |   |                            |      |      |      |       |
| Drain-to-Source Breakdown Voltage | V <sub>(BR)DSS</sub>                 | N   |   | I <sub>D</sub> = 250 μA    | 20   |      |      | V     |
|                                   |                                      | Р   | V <sub>GS</sub> = 0 V   | I <sub>D</sub> = -250 μA   | -20  |      |      |       |
| Drain-to-Source Breakdown Voltage | V <sub>(BR)DSS</sub> /T <sub>J</sub> | N   |   |                            |      | 10.4 |      | mV/°C |
| Temperature Coefficient           |                                      | Р   |   |                            |      | 9.95 |      |       |
| Zero Gate Voltage Drain Current   | I <sub>DSS</sub>                     | N   | V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 16 V                           |                            |      |      | 1.0  | μΑ    |
|                                   |                                      | Р   | V <sub>GS</sub> = 0 V, V <sub>DS</sub> = -16 V                          | T <sub>J</sub> = 25 °C     |      |      | -1.0 |       |
|                                   |                                      | N   | V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 16 V                           |                            |      |      | 10   |       |
|                                   |                                      | Р   | V <sub>GS</sub> = 0 V, V <sub>DS</sub> = -16 V                          | T <sub>J</sub> = 85 °C     |      |      | -10  |       |
| Gate-to-Source Leakage Current    | I <sub>GSS</sub>                     | N   | V <sub>DS</sub> = 0 V, V <sub>GS</sub> =                                | ±8.0 V                     |      |      | ±100 | nA    |
|                                   |                                      | Р   | V <sub>DS</sub> = 0 V, V <sub>GS</sub> =                                | ±8.0 V                     |      |      | ±100 |       |
| ON CHARACTERISTICS (Note 5)       | •                                    | •   |   |                            | •    |      | •    |       |
| Gate Threshold Voltage            | V <sub>GS(TH)</sub>                  | N   |   | I <sub>D</sub> = 250 μA    | 0.4  | 0.7  | 1.0  | V     |
|                                   |                                      | Р   | $V_{GS} = V_{DS}$   | I <sub>D</sub> = -250 μA   | -0.4 | -0.7 | -1.0 |       |
| Gate Threshold Temperature        | V <sub>GS(TH)</sub> /T <sub>J</sub>  | N   |   | 1                          |      | -3.0 |      | mV/°C |
| Coefficient                       |                                      | Р   | 1   |                            |      | 2.44 |      |       |
| Drain-to-Source On Resistance     | R <sub>DS(on)</sub>                  | N   | V <sub>GS</sub> = 4.5 V , I <sub>D</sub> = 3.8 A                        |                            |      | 37   | 65   | mΩ    |
|                                   |                                      | Р   | $V_{GS} = -4.5 \text{ V}$ , $I_D = -4.1 \text{ A}$                      |                            |      | 75   | 100  |       |
|                                   |                                      | N   | $V_{GS}$ = 2.5 V , $I_D$ = 2.0 A  |                            |      | 46   | 85   |       |
|                                   |                                      | Р   | V <sub>GS</sub> = 1.8 V , I <sub>D</sub> = 1.7 A                        |                            |      | 101  | 135  |       |
|                                   |                                      | N   |   |                            |      | 65   | 120  |       |
|                                   |                                      | Р   |   |                            |      | 150  | 200  |       |
| Forward Transconductance          | 9FS                                  | N   | V <sub>DS</sub> = 10 V, I <sub>D</sub> =                                | 1.7 A                      |      | 4.2  |      | S     |
|                                   |                                      | Р   | $V_{DS} = -5.0 \text{ V}$ , $I_D =$                                     | = -2.0 A                   |      | 3.1  |      |       |
| CHARGES, CAPACITANCES AND GA      | ATE RESISTAN                         | ICE   |   |                            |      |      |      |       |
| Input Capacitance                 | C <sub>ISS</sub>                     | N   |   | V <sub>DS</sub> = 10 V     |      | 271  |      | pF    |
|                                   |                                      | Р   |   | V <sub>DS</sub> = -10 V    |      | 531  |      |       |
| Output Capacitance                | C <sub>OSS</sub>                     | N   | f 40MU- 1/ 01/  | V <sub>DS</sub> = 10 V     |      | 72   |      |       |
|                                   |                                      | Р   | f = 1.0 MHz, V <sub>GS</sub> = 0 V                                      | V <sub>DS</sub> = -10 V    |      | 91   |      |       |
| Reverse Transfer Capacitance      | C <sub>RSS</sub>                     | N   |   | V <sub>DS</sub> = 10 V     |      | 43   |      |       |
|                                   |                                      | Р   |   | V <sub>DS</sub> = -10 V    |      | 56   |      |       |
| Total Gate Charge                 | Q <sub>G(TOT)</sub>                  | N   | V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 10 V, I <sub>D</sub> = 3.8 A |                            |      | 3.7  |      | nC    |
|                                   |                                      | Р   | $V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V}, I_D = -2.0 \text{ A}$ |                            |      | 5.5  |      |       |
| Threshold Gate Charge             | Q <sub>G(TH)</sub>                   | N   | V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 10 V, I <sub>D</sub> = 3.8 A |                            |      | 0.3  |      |       |
|                                   |                                      | P $V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V}, I_D = -2.0 \text{ A}$ |   |                            | 0.7  |      |      |       |
| Gate-to-Source Charge             | $Q_{GS}$                             | N   | $V_{GS} = 4.5 \text{ V}, V_{DS} = 10 \text{ V}, I_D = 3.8 \text{ A}$    |                            |      | 0.6  |      |       |
|                                   |                                      | Р   | $V_{GS} = -4.5 \text{ V}, V_{DS} = -10$                                 | V, I <sub>D</sub> = -2.0 A |      | 1.0  |      |       |
| Gate-to-Drain Charge              | $Q_{GD}$                             | N   | V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 10                           | V, I <sub>D</sub> = 3.8 A  |      | 1.0  |      |       |
|                                   |                                      | Р   | $V_{GS} = -4.5 \text{ V}, V_{DS} = -10$                                 | V, I <sub>D</sub> = -2.0 A |      | 1.4  |      | ]     |

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

| Parameter                | Symbol                              | N/P                      | Test Conditions  |                         | Min  | Тур   | Max  | Unit |
|--------------------------|-------------------------------------|--------------------------|--|-------------------------|------|-------|------|------|
| SWITCHING CHARACTERISTIC | S (Note 6)                          | •                        |  |                         | •    | •     | •    |      |
| Turn-On Delay Time       | t <sub>d(ON)</sub>                  |                          | N $V_{GS} = 4.5 \text{ V}, V_{DD} = 16 \text{ V},$ $I_{D} = 1.0 \text{ A}, R_{G} = 2.0 \Omega$ |                         |      | 3.8   |      | ns   |
| Rise Time                | t <sub>r</sub>                      | N                        |  |                         |      | 4.7   |      |      |
| Turn-Off Delay Time      | t <sub>d(OFF)</sub>                 |                          | I <sub>D</sub> = 1.0 A, R <sub>G</sub> =   | 2.0 Ω                   |      | 11.1  |      |      |
| Fall Time                | t <sub>f</sub>                      | 1                        |  |                         |      | 5.8   |      |      |
| Turn-On Delay Time       | t <sub>d(ON)</sub>                  |                          |  |                         |      | 5.2   |      |      |
| Rise Time                | t <sub>r</sub>                      | ٦ _                      | $V_{GS} = -4.5 \text{ V}, V_{DD}$  | = -10 V,                |      | 13.2  |      |      |
| Turn-Off Delay Time      | t <sub>d(OFF)</sub>                 | P                        | $I_D = -2.0 \text{ A, } R_G =$   | 2.0 Ω                   |      | 13.7  |      |      |
| Fall Time                | t <sub>f</sub>                      |                          |  |                         |      | 19.1  |      |      |
| DRAIN-SOURCE DIODE CHAR  | ACTERISTICS                         | •                        |  |                         | •    | •     | •    |      |
| Forward Diode Voltage    | V <sub>SD</sub>                     | N                        |  | I <sub>S</sub> = 1.0 A  |      | 0.69  | 1.0  | V    |
|                          |                                     | Р                        |  | I <sub>S</sub> = -1.0 A |      | -0.75 | -1.0 |      |
|                          |                                     | N                        |  | I <sub>S</sub> = 1.0 A  |      | 0.52  |      |      |
|                          |                                     | Р                        |  | I <sub>S</sub> = -1.0 A |      | -0.64 |      |      |
| Reverse Recovery Time    | rse Recovery Time t <sub>RR</sub> N |                          | I <sub>S</sub> = 1.0 A   |                         | 10.2 |       | ns   |      |
|                          |                                     | Р                        |  | I <sub>S</sub> = -1.0 A |      | 16.2  |      |      |
| Charge Time              | t <sub>a</sub>                      | N                        | 1  | I <sub>S</sub> = 1.0 A  |      | 6.0   |      |      |
|                          |                                     | P V <sub>GS</sub> = 0 V, | I <sub>S</sub> = -1.0 A  |                         | 10.6 |       |      |      |
| Discharge Time           | t <sub>b</sub>                      | N                        | -II / -II - 400 A / -  | I <sub>S</sub> = 1.0 A  |      | 4.2   |      |      |
|                          |                                     | Р                        |  | I <sub>S</sub> = -1.0 A |      | 5.6   |      |      |
| Reverse Recovery Charge  | Q <sub>RR</sub>                     | N                        |  | I <sub>S</sub> = 1.0 A  |      | 3.0   |      | nC   |
|                          |                                     | P                        |  | I <sub>S</sub> = -1.0 A |      | 5.7   |      |      |

<sup>5.</sup> Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

## $\textbf{TYPICAL PERFORMANCE CURVES - N-CHANNEL} \ (T_J = 25^{\circ}C \ unless \ otherwise \ noted)$

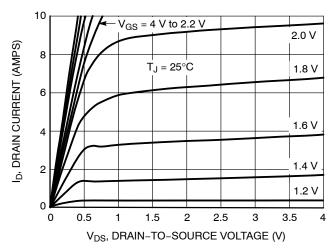


Figure 1. On-Region Characteristics

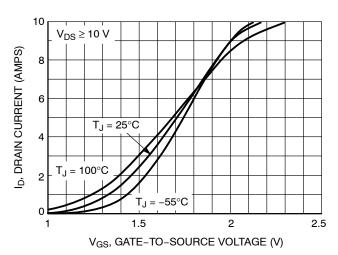


Figure 2. Transfer Characteristics

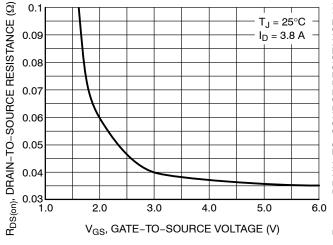


Figure 3. On-Resistance versus Drain Current

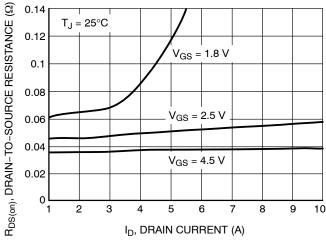


Figure 4. On-Resistance versus Drain Current and Gate Voltage

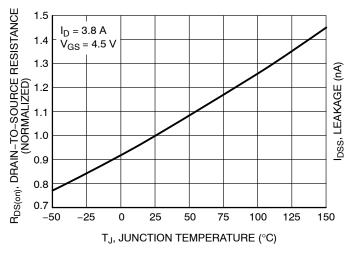


Figure 5. On–Resistance Variation with Temperature

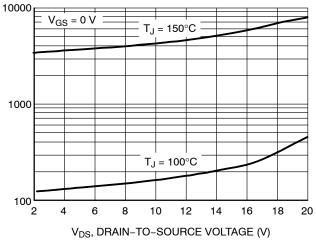
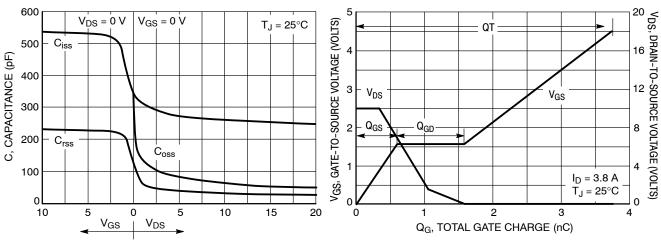


Figure 6. Drain-to-Source Leakage Current versus Voltage

## TYPICAL PERFORMANCE CURVES - N-CHANNEL (T<sub>J</sub> = 25°C unless otherwise noted)



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (V)

Figure 7. Capacitance Variation

Figure 8. Gate-To-Source and Drain-To-Source Voltage versus Total Charge

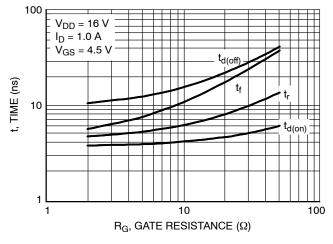


Figure 9. Resistive Switching Time Variation versus Gate Resistance

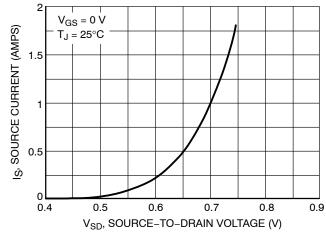


Figure 10. Diode Forward Voltage versus Current

## $\textbf{TYPICAL PERFORMANCE CURVES - P-CHANNEL} \ (T_J = 25^{\circ}\text{C unless otherwise noted})$

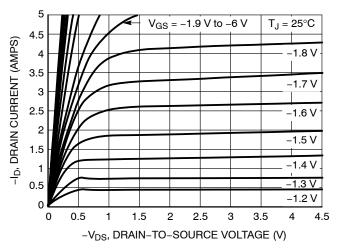
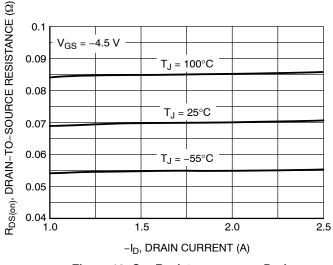


Figure 11. On-Region Characteristics

Figure 12. Transfer Characteristics



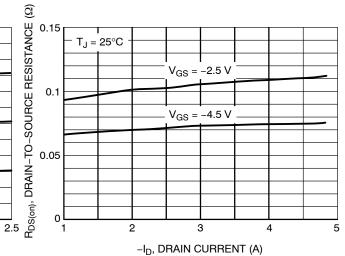
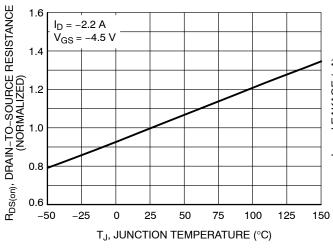


Figure 13. On-Resistance versus Drain Current

Figure 14. On-Resistance versus Drain Current and Gate Voltage





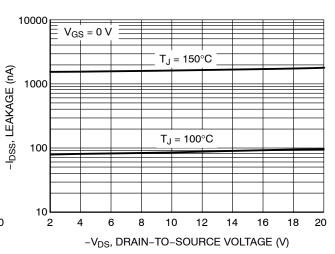
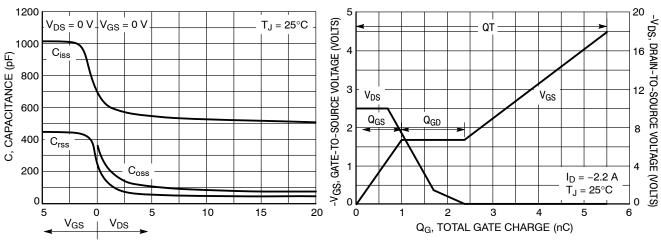


Figure 16. Drain-to-Source Leakage Current versus Voltage

## $\textbf{TYPICAL PERFORMANCE CURVES} - \textbf{P-CHANNEL} \ (\textbf{T}_{J} = 25^{\circ} \textbf{C} \ unless \ otherwise \ noted)$



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (V)

Figure 17. Capacitance Variation

Figure 18. Gate-To-Source and Drain-To-Source Voltage versus Total Charge

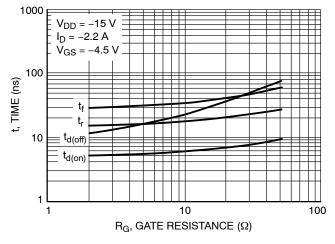


Figure 19. Resistive Switching Time Variation versus Gate Resistance

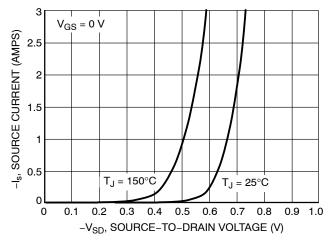


Figure 20. Diode Forward Voltage versus Current

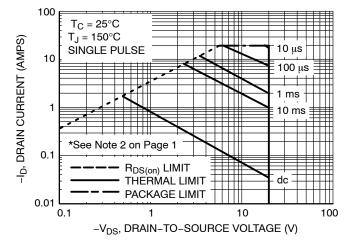


Figure 21. Maximum Rated Forward Biased Safe Operating Area

## TYPICAL PERFORMANCE CURVES (T $_{J}$ = 25°C unless otherwise noted)

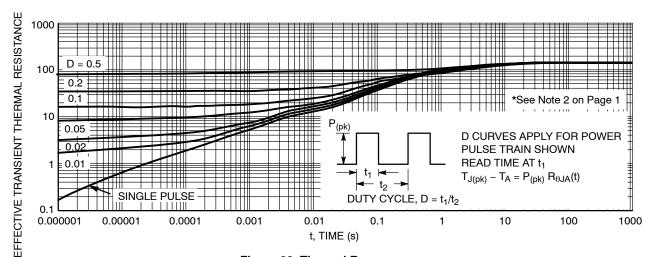
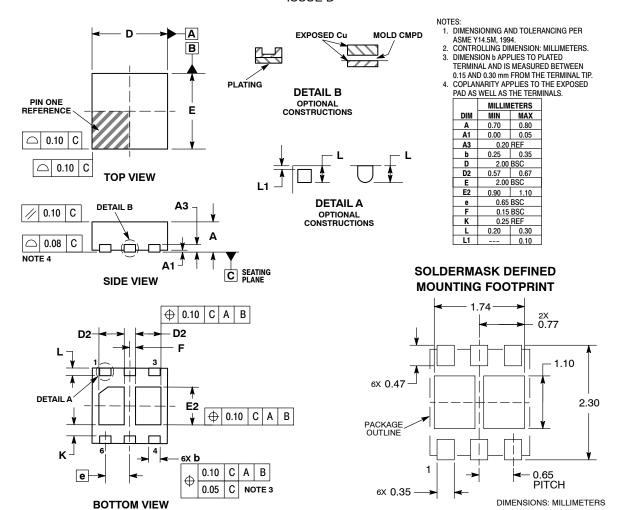


Figure 22. Thermal Response

#### PACKAGE DIMENSIONS

# **WDFN6, 2x2, 0.65P**CASE 506AN-01 ISSUE D



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